

Radiation-Hard Silicon Strip Sensors for the ATLAS Phase-2 Upgrade

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on behalf of ATLAS Collaboration



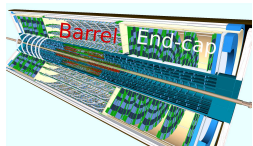
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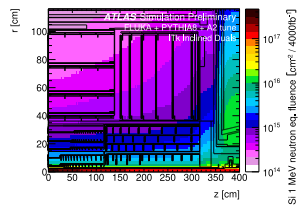


● ATLAS Inner Tracker (ITk) strip sensors:

- Single-sided n^+ -in-p manufactured on 6" wafers,
- Thickness $(300 - 320) \mu\text{m}$,
- Al strips AC-coupled to n^+ implants grounded via polysilicon bias resistors,
- Strip isolation by common p-stop,
- 8 different designs: Barrel region (Short strips (SS) and Long strips (LS)) and End-cap region (R0-R5).



Visualisation of ITk [1]



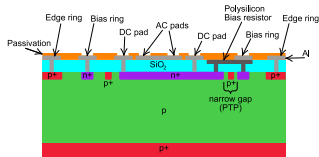
Fluence distribution for ITk [2]

● Expected maximal radiation fluences (incl. safety factor 1.5):

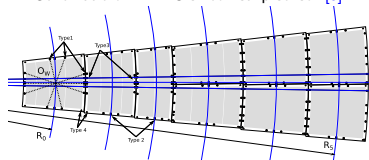
- Short strip barrel: $1.1 \cdot 10^{15} \text{ n}_{\text{eq}} \text{cm}^{-2}$,
- Strip end-cap: $1.6 \cdot 10^{15} \text{ n}_{\text{eq}} \text{cm}^{-2}$.

● Radiation damage:

- **Bulk damage** – Increase in leakage current, increase in full-depletion voltage and reduction in charge collection efficiency (CCE).
- **Surface damage** – Cause for early break-down voltages, decrease of interstrip resistance, reduced channel isolation.



Schematic of ATLAS silicon strip sensor [3]

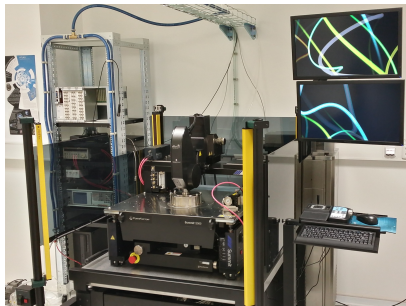


ITk end-cap sensors [4]

- Program consists of:
 - QC: Tests on MAIN Sensors to be assembled in modules:
 - Tests on every sensor: Visual inspection, IV, CV, metrology.
 - Tests on sample sensors: Leakage current stability, full strip tests, detailed strip tests.
 - QA: Sample tests performed on miniature sensors and test structures:
 - Tests before irradiation.
 - Irradiation.
 - Tests after irradiation

- Irradiation sites:

Particle type	Site
Protons	CYRIC, Tohoku Uni (70 MeV) Birmingham (28 MeV)
Neutrons	Ljubljana TRIGA reactor
Gammas	UJP Praha (^{60}Co)

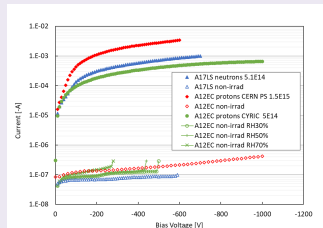


- Institutions & tests:

Site	QC	Irrad.	QA (CCE)	QA (TC)	Comment
Cambridge	x				
QMUL	x				
KEK/Tsukuba	x	x	x	x	QC in collaboration with HPK Only long-term tests
SCIPP	x				
Vancouver cluster	x				
Carleton	x				
Prague	x	x		x	
Birmingham		x	x	x	
Ljubljana		x	x		
Toronto			x	x	
Valencia			x		
CNM				x	

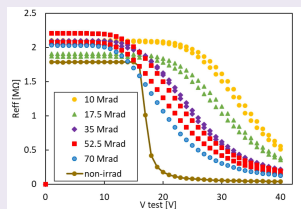
Effect of irradiation on measured sensor characteristics

Leakage current [3]



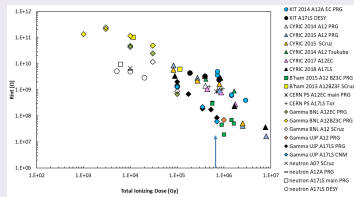
- Irradiated sensors were measured at cold.
- Non-irr. sensors were measured at 20 °C.

Effective PTP resistance vs V_{test} [3]



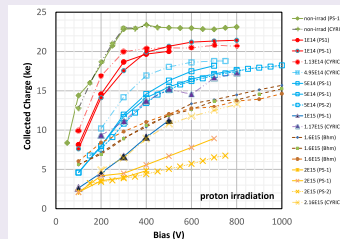
- ATLAS17LS mini sensor irr. by gammas to different TID.

Interstrip resistance vs TID [3]



- Comparison for sensor prototypes ATLAS17LS, ATLAS12EC, ATLAS07 and ATLAS12.

Charge collection vs bias voltage



- Compared results for proton irr. at CERN-PS, CYRIC and Birmingham.